Am2912

Quad Bus Transceiver

DISTINCTIVE CHARACTERISTICS

- · Input to bus is inverting
- Quad high-speed open collector bus transceiver
- Driver outputs can sink 100mA at 0.8V maximum
- Bus compatible with Am2905, Am2906, Am2907
- Advanced Schottky processing
- PNP inputs to reduce input loading

GENERAL DESCRIPTION

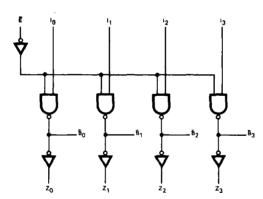
The Am2912 is a quad Bus Transceiver consisting of four high-speed bus drivers with open-collector outputs capable of sinking 100mA at 0.8 volts and four high-speed bus receivers. Each driver output is connected internally to the high-speed bus receiver in addition to being connected to the package pin. The receiver has a Schottky TTL output capable of driving 10 Schottky TTL unit loads.

An active LOW enable gate controls the four drivers so that outputs of different device drivers can be connected together for party-line operation. The enable input can be conveniently driven by active LOW decoders such as the Am25L\$139.

The bus output high-drive capability in the LOW state allows party-line operation with a line impedance as low as 100Ω . The line can be terminated at both ends, and still give considerable noise margin at the receiver. The receiver typical switching point is 2.0 volts.

The Am2912 features advanced Schottky processing to minimize propagation delay. The device package also has two ground pins to improve ground current handling and allow close decoupling between V_{CC} and ground at the package. Both GND₁ and GND₂ should be tied to the ground bus external to the device package.

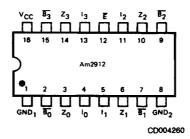
BLOCK DIAGRAM



BD002130

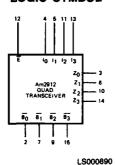
CONNECTION DIAGRAM Top View

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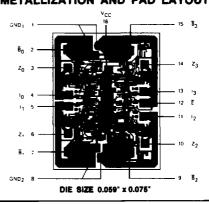


Note: Pin 1 is marked for orientation

LOGIC SYMBOL

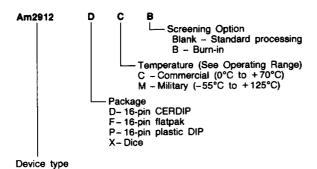


METALLIZATION AND PAD LAYOUT



ORDERING INFORMATION

AMD products are available in several packages and operating ranges. The order number is formed by a combination of the following: Device number, speed option (if applicable), package type, operating range and screening option (if desired).



Quad Bus Transceiver

Valid Combinations					
Am2912	PC DC, DCB, DM, DMB FM, FMB XC, XM				

Valid Combinations

Consult the AMD sales office in your area to determine if a device is currently available in the combination you wish.

PIN DESCRIPTION

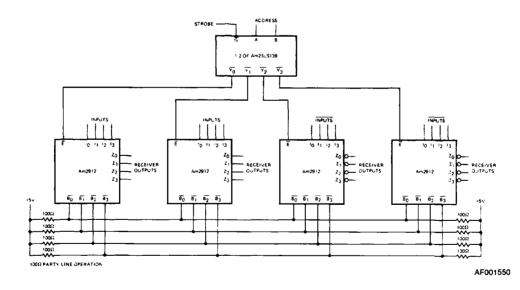
Pin No.	Name	1/0	Description
4, 5, 11, 13	1 ₀ , 1 ₁ , 1 ₂ , 1 ₃	1	The four driver inputs.
12	Ē	1	Enable. When the Enable is HIGH, the four drivers are disabled.
2, 7, 9, 15	B ₀ , B ₁ , B ₂ , B ₃	1/0	The four driver outputs and receiver inputs (data is inverted).
3, 6, 10, 14	Z ₀ , Z ₁ , Z ₂ , Z ₃	0	The four receiver outputs. Data from the bus is inverted while data from the t inputs is non-inverted.

TRUTH TABLE

Inputs		Outputs			
Ē	П	B	Z		
L	L	Н	L		
L	H	L	н		
н	Х	Y	7		

H = HIGH Voltage Level
L = LOW Voltage Level
X = Don't Care
Y = Voltage Level of Bus
(Assumes Control by Another
Bus Transceiver)

TYPICAL APPLICATION



ABSOLUTE MAXIMUM RATINGS

Storage Temperature65°C to +150°C
(Ambient) Temperature Under Bias55°C to +125°C
Supply Voltage to Ground Potential
Continuous0,5V to +7.0V
DC Voltage Applied to Outputs For
High Output State0.5V to +V _{CC} max
DC Input Voltage0.5V to +5.5V
DC Output Current, Into Bus200mA
DC Output Current, Into Outputs
(Except Bus) 30mA
DC Input Current

Stresses above those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent device failure. Functionality at or above these limits is not implied. Exposure to absolute maximum ratings for extended periods may affect device reliability.

OPERATING RANGES

0°C to +70°C
.+4.75V to +5.25V
55°C to +125°C
+4.5V to +5.5V
r which the function-

DC CHARACTERISTICS over operating range unless otherwise specified

Parameters	Description	Test Conditions (Note 2)		Min	Typ (Note 1)	Max	Units	
., Output HIGH Voltage	V _{CC} = MIN, I _{OH} = - 1.0mA	MIL	2.5	3.4				
VOH	(Receiver Outputs)	VIN = VIL or VIH	COM'L	2.7	3.4		Volts	
VOL	Output LOW Voltage (Receiver Outputs)	V _{CC} = MIN, I _{OL} = 20mA V _{IN} = V _{IL} or V _{IH}				0.5	Volts	
VIH	Input HIGH Level (Except Bus)	Guaranteed input logical HIGH for all inputs		2.0			Volts	
VIL	Input LOW Level (Except Bus)	Guaranteed input logical LOW for all inputs				0.8	Volts	
VI	Input Clamp Voltage (Except Bus)	V _{CC} = MIN, I _{IN} = -18mA				-1.2	Volts	
	Input LOW Current			Enable		L	-0.36	.
1L	(Except Bus)	V _{CC} = MAX, V _{IN} = 0.4V	MAX, V _{IN} = 0.4V Data			-0.54	mA	
	Input HIGH Current		Enable			20		
ŀН	(Except Bus)	V _{CC} = MAX, V _{IN} = 2.7V	Data			30	μΑ	
l _l	Input HIGH Current (Except Bus)	V _{CC} = MAX, V _{IN} = 5.5V				100	μА	
	Output Short Circuit Current		MIL	-20		-55	Ī .	
ISC	(Except Bus)	V _{CC} = MAX (Note 3)	COM'L	- 18		-60	mA	
ICCL	Power Supply Current (All Bus Outputs LOW)	V _{CC} = MAX Enable = GND			45	70	mA	

Notes: 1. Typical limits are at V_{CC} = 5.0V, 25°C ambient and maximum loading.
2. For conditions shown as MIN or MAX, use the appropriate value specified under Operating Ranges for the applicable device type.
3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

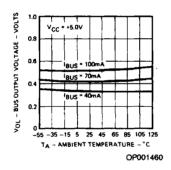
BUS INPUT/OUTPUT CHARACTERISTICS over operating temperature range

Parameters	Description	Test C	Min	Typ (Note 1)	Max	Units		
				I _{OL} = 40mA		0.33	0.5	
		ľ	MIL	I _{OL} = 70mA		0.42	0.7	Volts
VOL	Output LOW Voltage	V _{CC} = MIN		I _{OL} = 100mA		0.51	0.8	
•00	Capar 2017 Total	1.00		I _{OL} = 40mA		0.33	0.5	
			COMIL	IOL = 70mA	-	0.42	0.7	
			I _{OL} = 100mA		0.51	0.8	Ī	
				V _O = 0.8V			-50	
•	B Loster Comme		MIL	V _O = 4.5V			200	1
ю	Bus Leakage Current	V _{CC} = MAX	COM'L	V _O = 4.5V			100	μА
loff	Bus Leakage Current (Power Off)	V _O = 4.5V	V _O = 4.5V				100	μА
		Bus Enable = 2.4V V _{CC} = MAX	IV	MIL	2.4	2.0		
V _{TH}	Receiver Input HIGH Threshold		COM'L	2.25	2.0		Voits	
		Input LOW Threshold Bus Enable = 2.4V MIL COM'L COM'L	ıv	MIL		2.0	1.6	
VTL			COM'L		2.0	1.75	Volts	

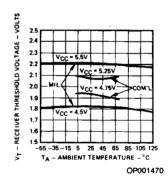
Notes: 1. Typical limits are at V_{CC} = 5.0V, 25°C ambient and maximum loading.
2. For conditions shown as MIN or MAX, use the appropriate value specified under Operating Ranges for the applicable device type.
3. Not more than one output should be shorted at a time. Duration of the short circuit test should not exceed one second.

TYPICAL PERFORMANCE CURVES

Typical Bus Output Low Voltage Versus Ambient Temperature



Receiver Threshold Variation Versus Ambient Temperature

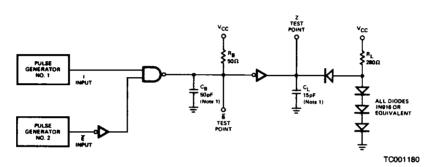


SWITCHING CHARACTERISTICS ($T_A = +25$ °C, $V_{CC} = 5.0$ V)

Parameters	Description	Test Conditions	Min	Тур	Max	Units
tplH	Data Input to Bus			10	15	
t _{PHL}	Data input to bus	R _B = 50 Ω C _B = 50 pF (Note 1)		10	15	ns
tPLH .	Enable Input to Bus			14	18	
t PHL	chapie input to bus			13	18	ns
t _{PLH}	Bus to Receiver Out	$R_B = 50 \Omega$, $R_L = 280 \Omega$ $C_B = 50 pF$ (Note 1), $C_L = 15 pF$		10	15	
tpHL	DUS TO RECEIVE OUT	C _B = 50 pF (Note 1), C _L = 15 pF		10	15	ns
tr	Bus	R _B = 50 Ω	4.0	10		ns
ty	Bus	C _B = 50 pF (Note 1)	2.0	4.0		ns

Note 1, includes probe and jig capacitance.

SWITCHING TEST CIRCUIT



Note 1. Include Probe and Jig Capacitance.

SWITCHING WAVEFORMS

